

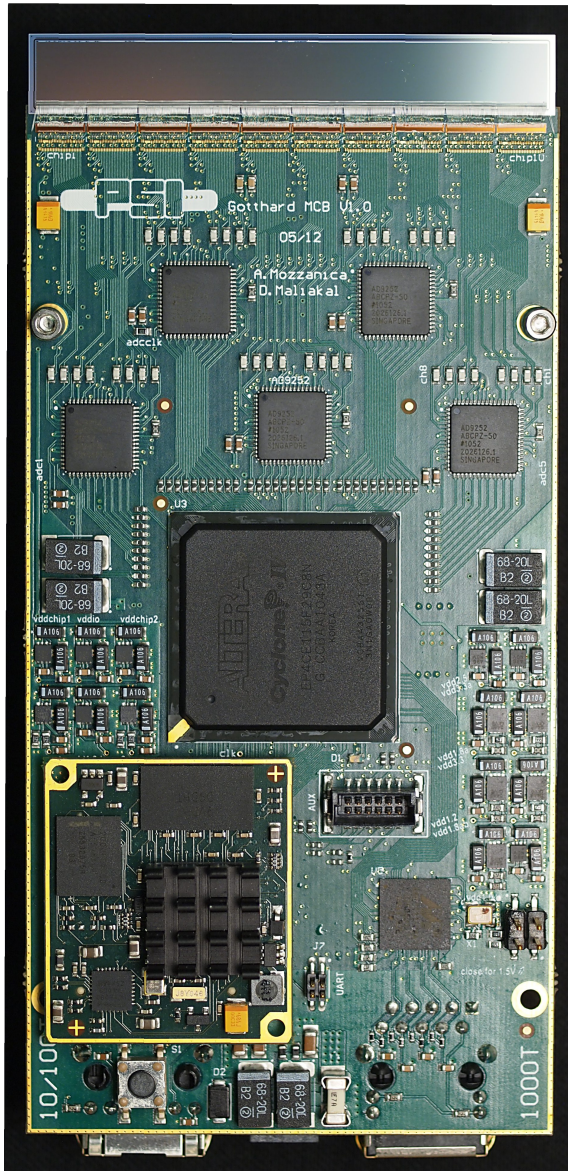


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GotthardII development status

XDAC Meeting, 14.12.2016

Reminder: GotthardI

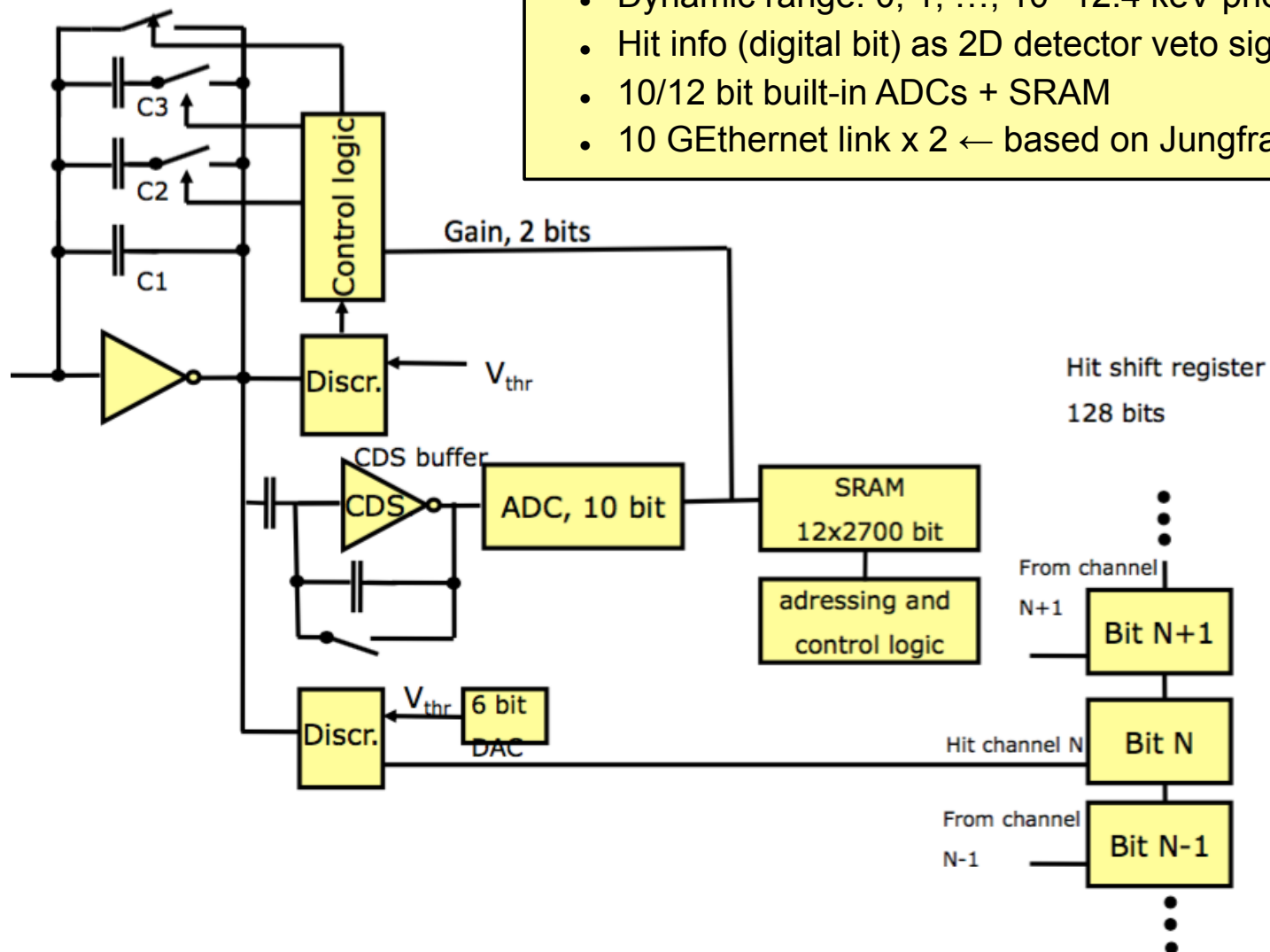


- 67mm x 130mm
- 50 μm pitch, 1280ch/module (same as MYTHEN)
- 10 chips, 4 analog outputs per chip
- 40 ADC channels @32Mhz, 14bits
- Gbit Ethernet data transfer for readout
- 100M Ethernet for slow control/setup
- Fast readout (1MHz) with ~600 bunches per EU-XFEL train measurable (memory for ~350)
- 60kHz continuous frame rate
- Integration in detector class for software control (same as Jungfrau)
- Developed in collaboration with Desy
- Start with GotthardI and replace it with GotthardII



Reminder of Gotthard-II: Schematic

- 4.5 MHz frame rate $\leftarrow$ bunch structure of the Eu-XFEL
- Dynamic range: 0, 1, ..., 10^4 12.4 keV photons
- Hit info (digital bit) as 2D detector veto signal
- 10/12 bit built-in ADCs + SRAM
- 10 GEthernet link x 2 $\leftarrow$ based on Jungfrau read-out





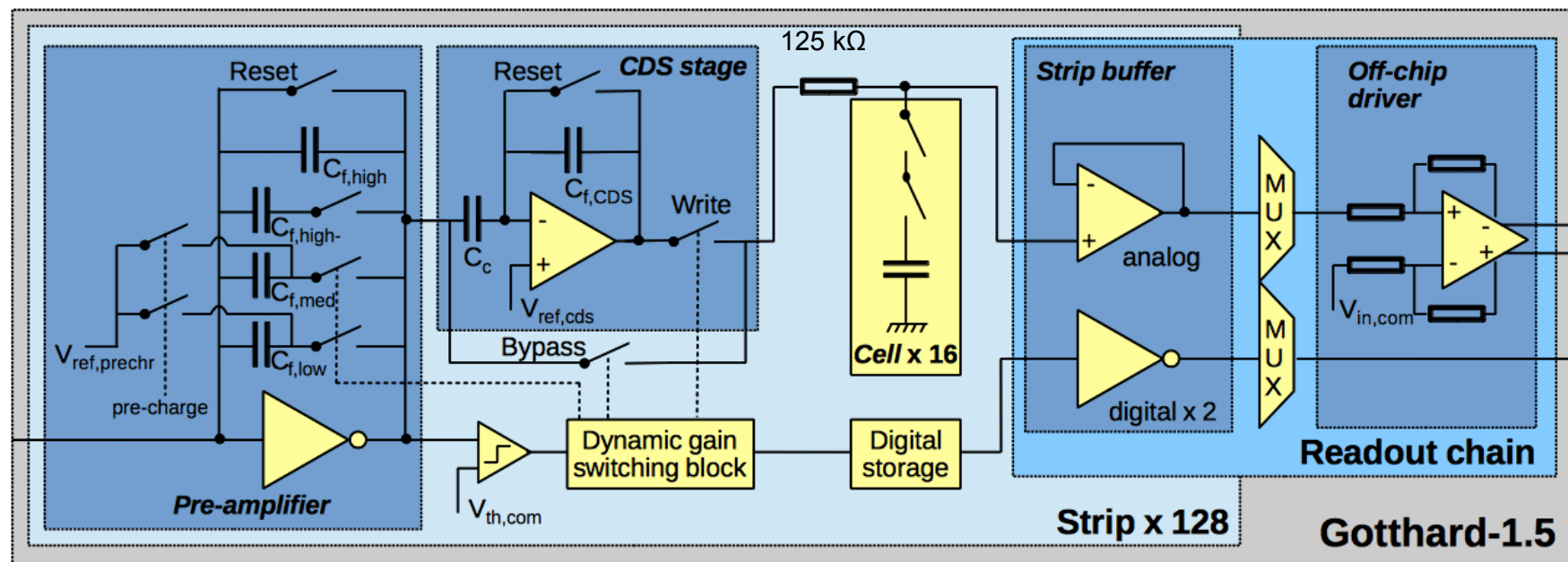
Outline

- Analogue Front End
 - Gotthard-1.4(&1.5) front-end problems
 - New analogue Front End Gotthard-1.7 first results
- ADC
 - Old ADC problems
 - New ADC, first results
- Current status

New FE and ADC were submitted in MPW in July
Received back beginning of December
results brand new and preliminary...

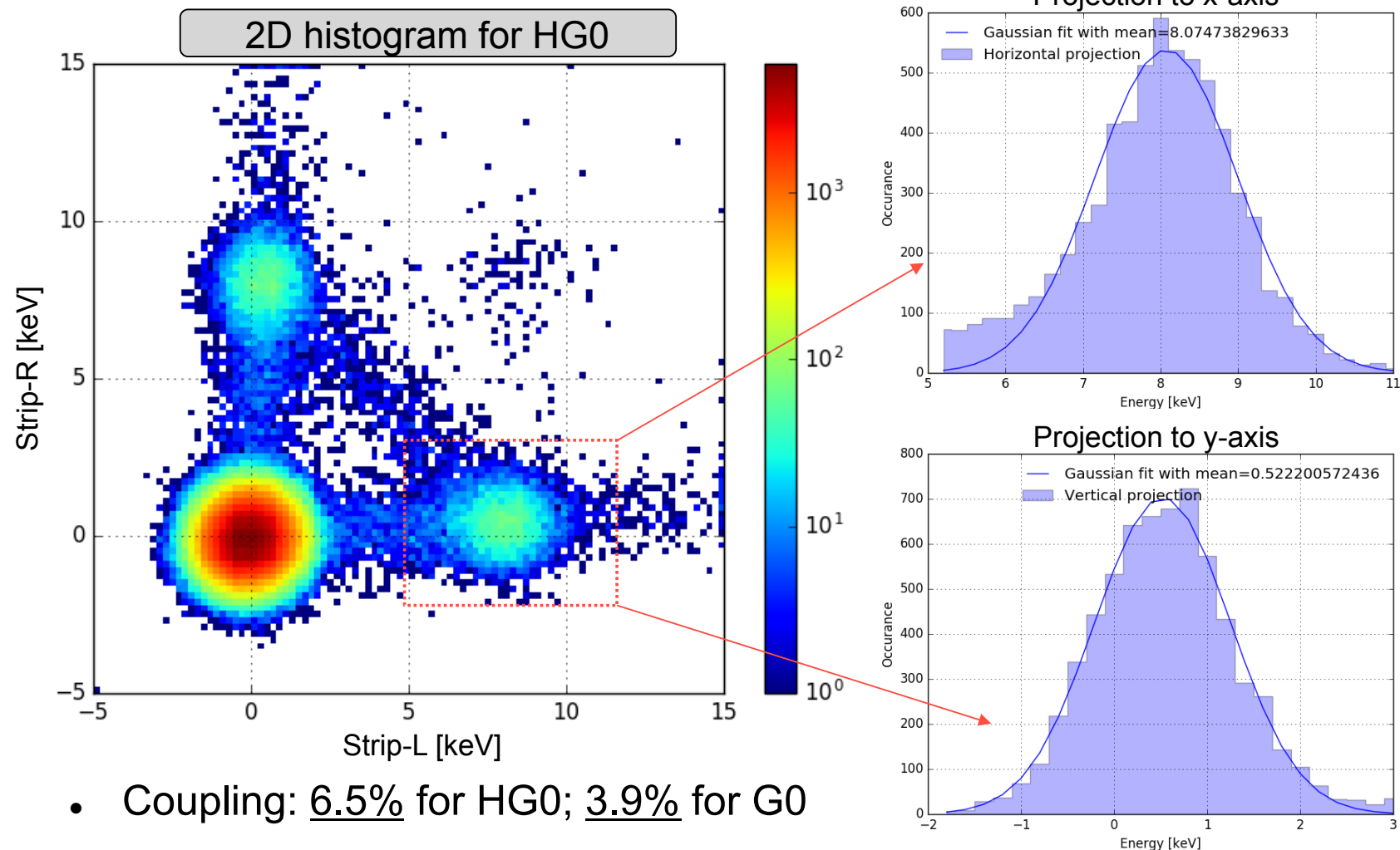
Gotthard-1.4&1.5 Architecture

- To convert the GotthardI design from IBM 130nm to UMC 110nm we used the Jungfrau design and just scaled preamp
- The noise performance was good (175 e^- in G0), but the speed was too slow (forgot to remove the 125k resistor) and the capacitive cross talk due to the too low DC gain was too high
- Decided to submit new analogue FE with high DC gain



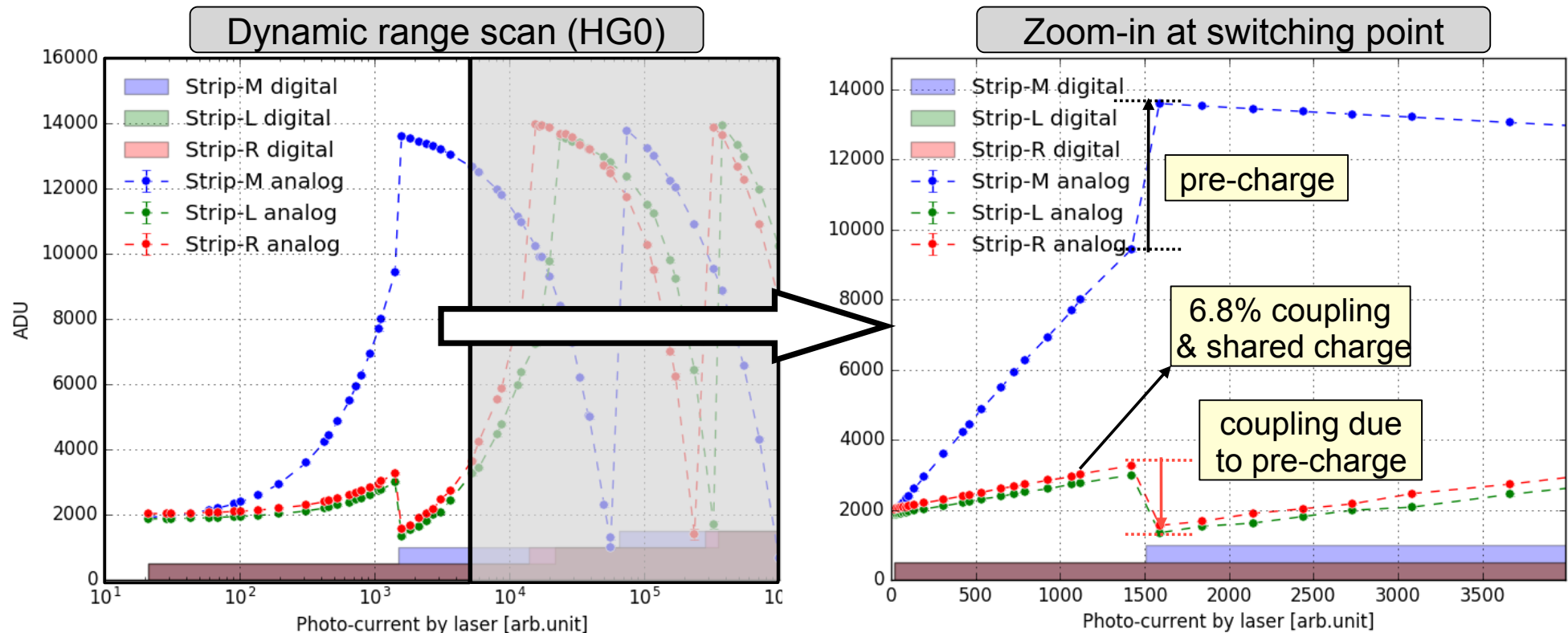
Coupling in 1.4&1.5: Low rate X-ray measurement

- Low rate X-ray measurement: 0 or 1 ph entry



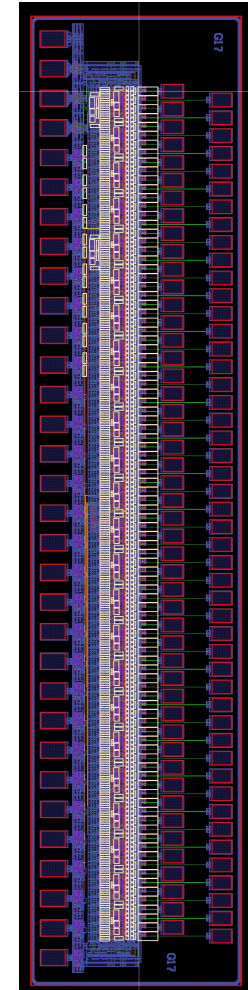
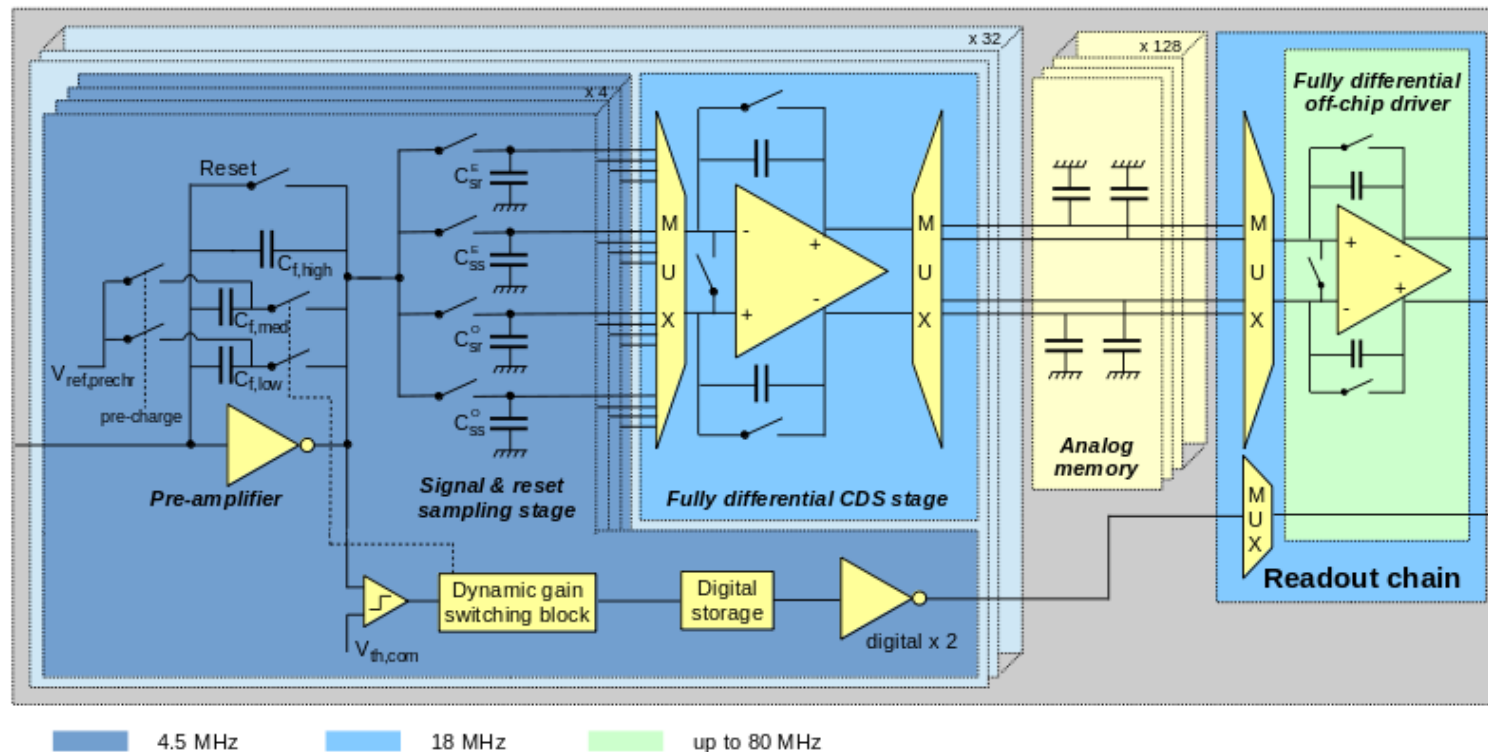
Coupling in 1.4&1.5 to neighbouring channels

- Laser injection into a single channel
- Charge in neighbouring strip in high gain: 6.8% coupling
- Charge loss (4.6 photons) in neighbouring strips when channel switches



New FE: Gotthard-1.7

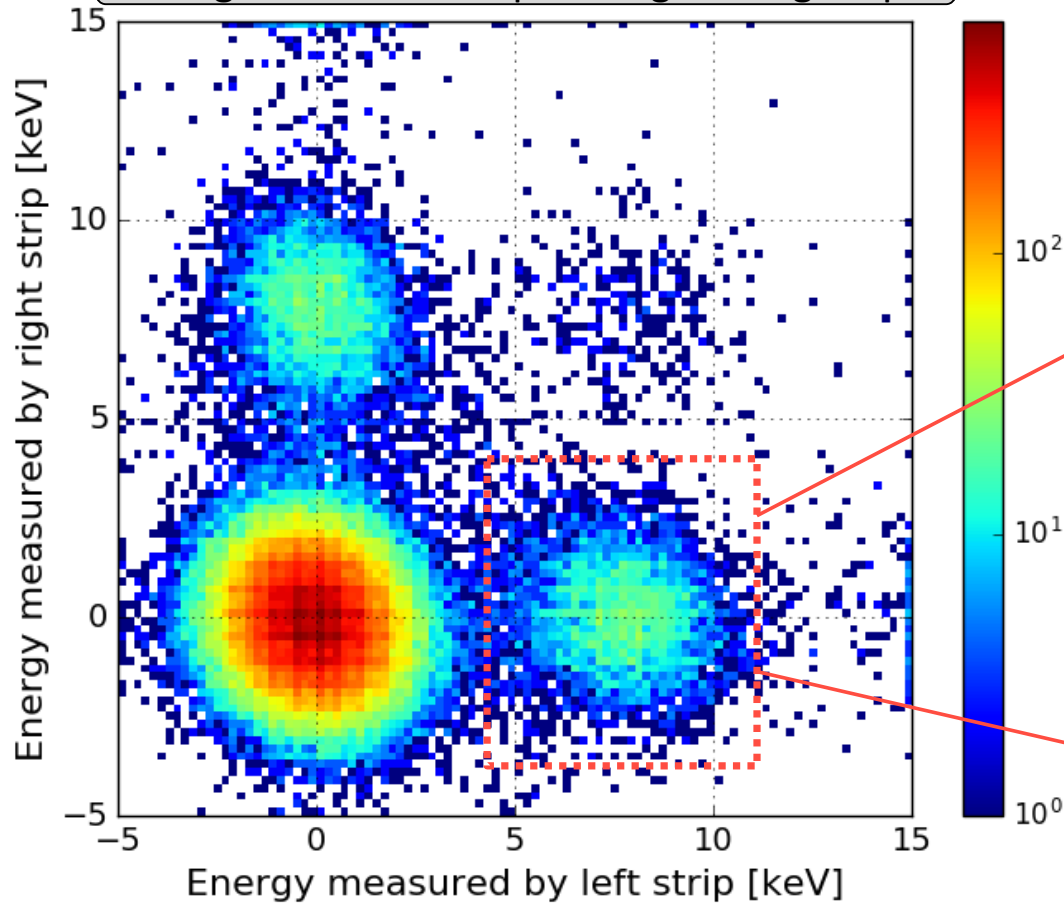
- Development of high DC gain, fully differential front-end G-1.7
 - High DC gain pre-amplifier (750-950 for $V_{dd}=1.2-1.4$ V)
 - Continuous CDS sampling at > 18 MHz
 - Differential output fits to ADC



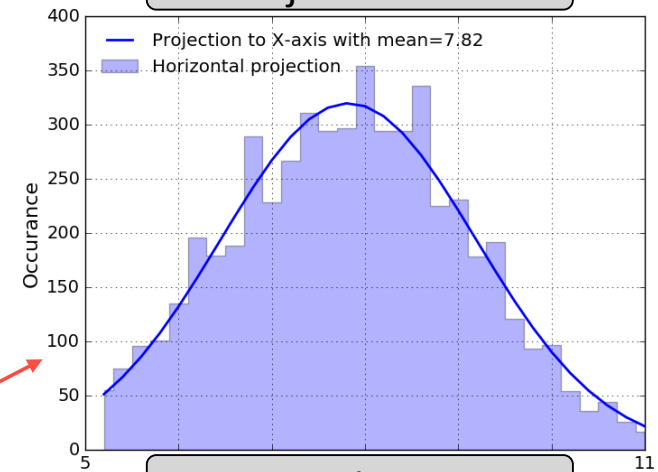
Coupling in Gotthard-1.7

- Strip-to-strip coupling: X-ray fluorescence measurement

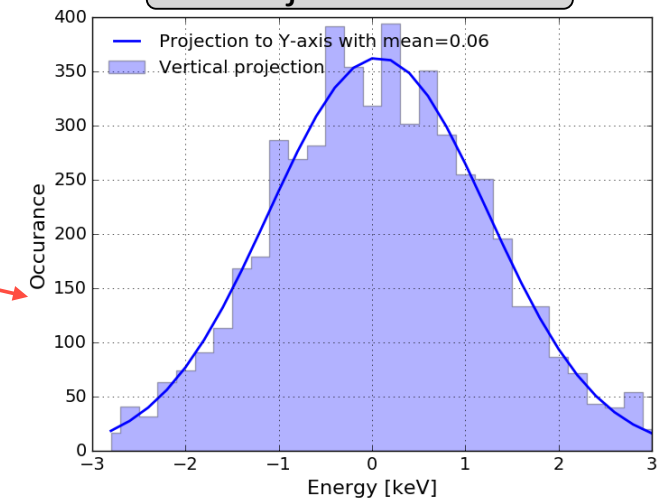
Charge collection map of neighboring strips



Projection to X



Projection to Y



- G-1.7: $\sim 0.8\%$ (G-1.5: 6.8%)

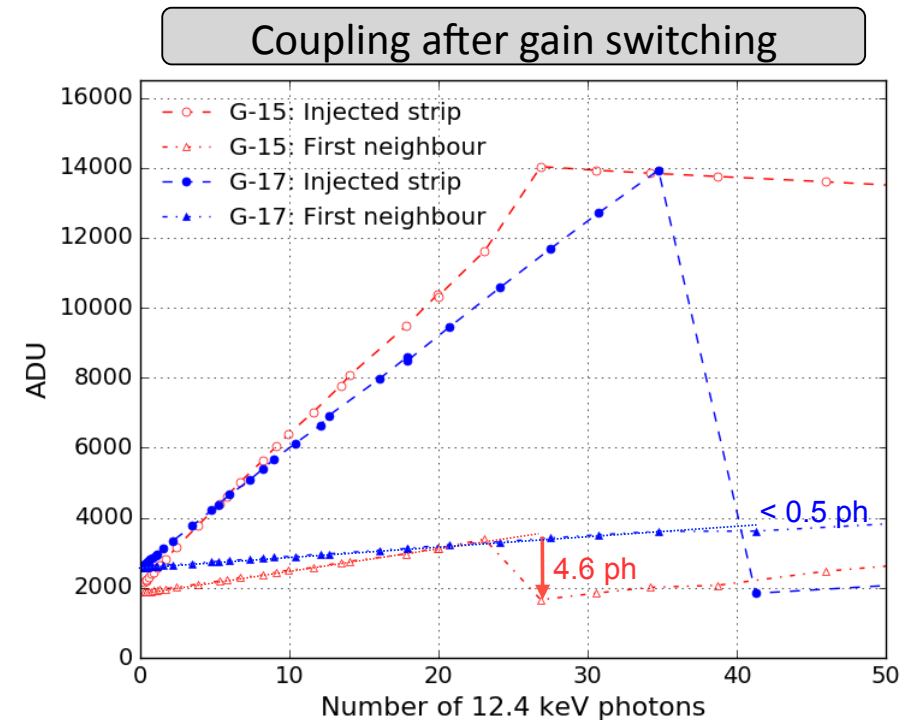
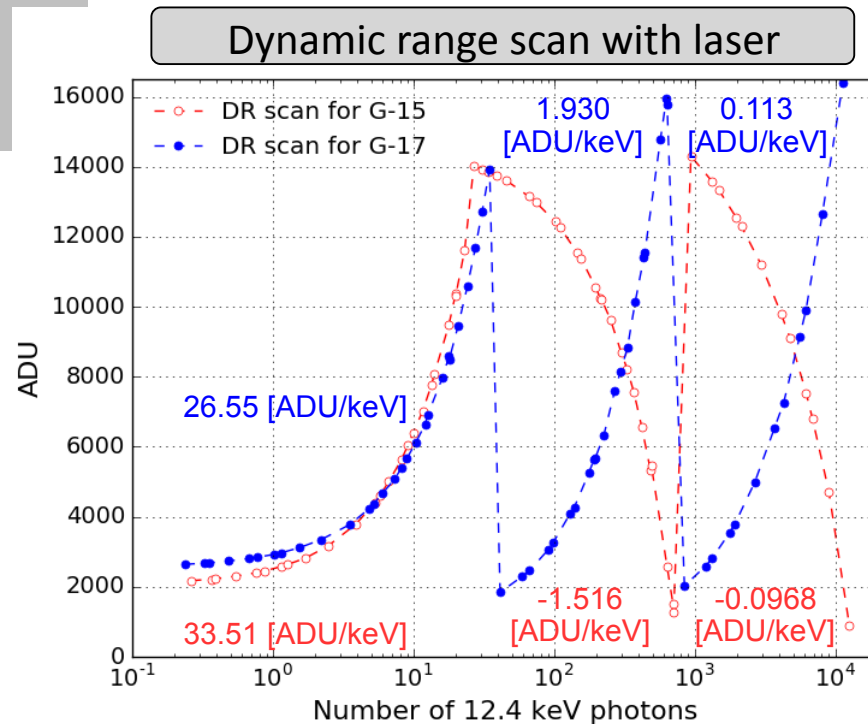
High DC gain reduces strip-to-strip coupling!

$$\text{Coupling} = \frac{1}{A} \cdot \frac{C_{\text{int}}}{C_f + C_{\text{para}}}$$

Dynamic range and coupling in G-1.7

- Dynamic range: Infrared laser injection into center of a strip

- G-1.5: 12570 x 12.4 keV photons, G-1.7: 11260 x 12.4 keV photons



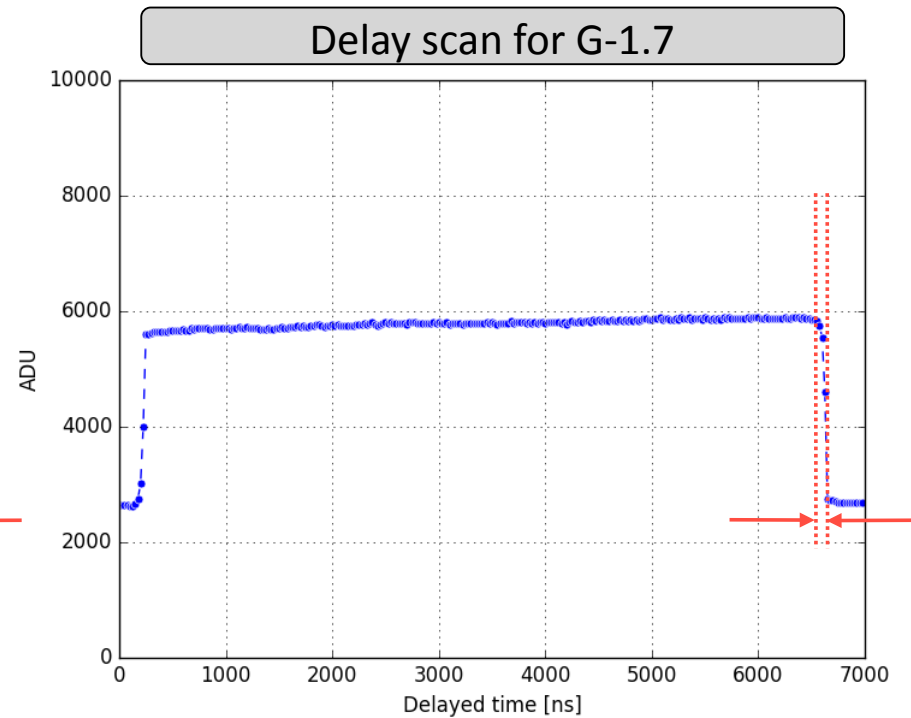
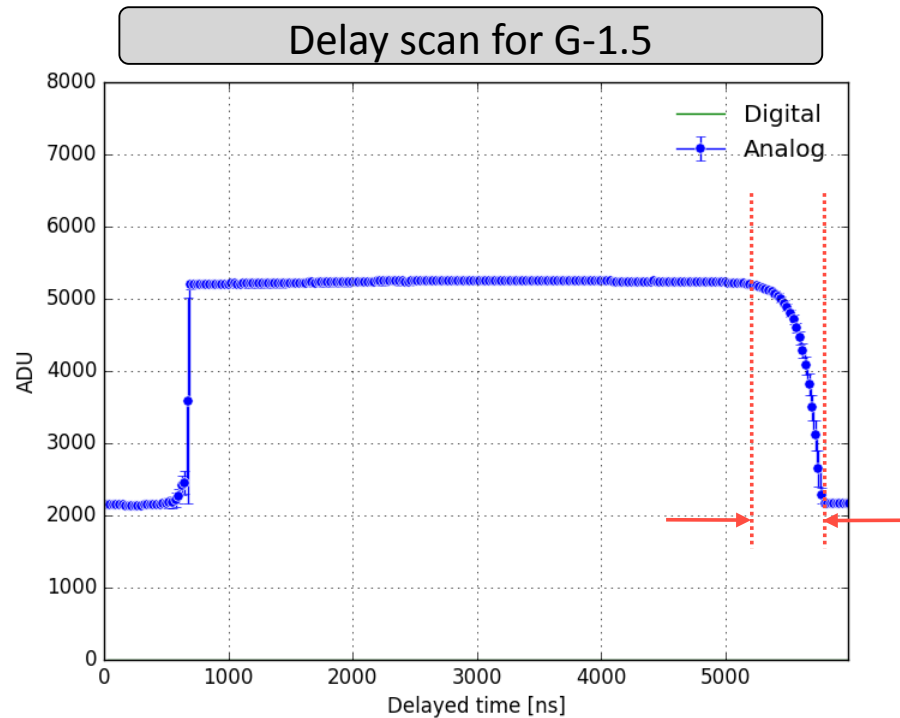
- “Charge loss” to neighbouring strip after gain switching

- G-1.5: ~ 4.6 x 12.4 keV photons, G-1.7: ~ 0.47 x 12.4 keV photons

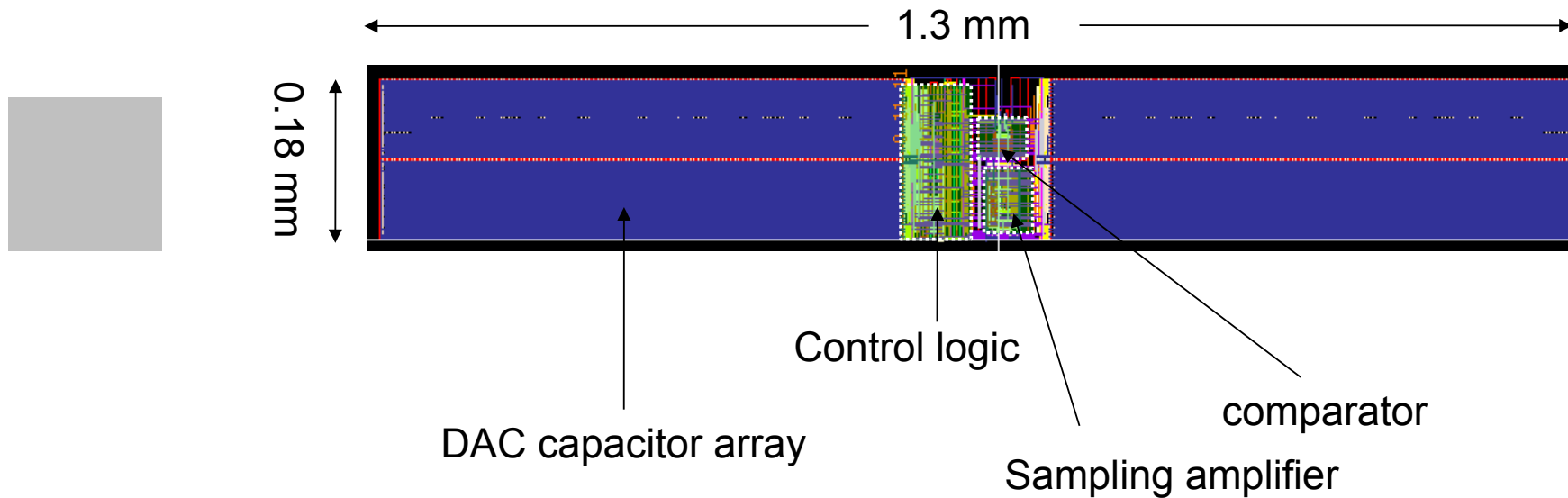
Significant reduction in coupling reduces the complexity of calibration!

Settling time in Gotthard-1.7

- Settling time: Laser delay scan
 - **G-1.5: 500-600 ns** → limited by a serial resistor
 - **G-1.7: ~ 50-75 ns** for signal settling
 - For 100-150 ns integration time, enough time for charge collection



Old ADC design problems



Specification:

- Resolution 12 bit
- Sampling frequency 20 MHz
- Power supply voltage 1.2V
- Input Signal Range ± 0.8 V $\rightarrow$ 1 LSB = 390 μ V

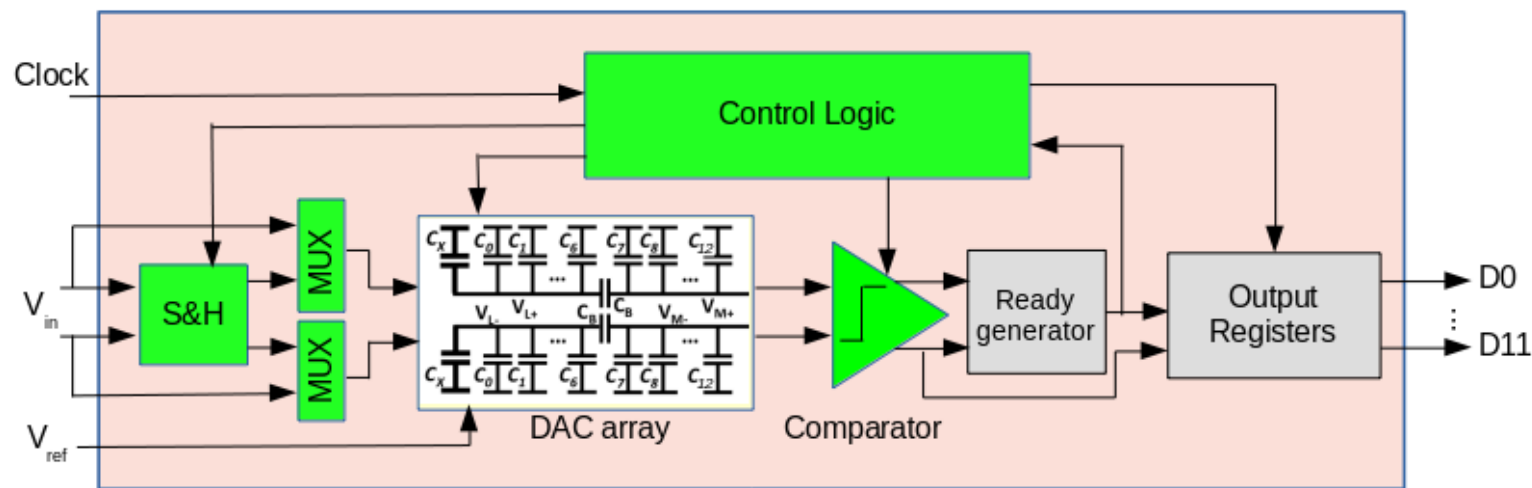
However:

- Sampling frequency was <8MHz, comparator too slow due to parasitics in layout
- Last 4 bits not stable, problem with comparator ready signal

New ADC-0.2 12-bit

- Speed of comparator: > 20 MHz sampling rate (one ADC for 4 channels)
- Split-capacitor DAC array $\rightarrow$ total capacitance and charging time $\downarrow$
- Adjustable delay in control logic for DAC & comparator synchronization
- Area of $180 \times 520 \mu\text{m}^2$ per ADC (old ADC $180 \times 1300 \mu\text{m}^2$)

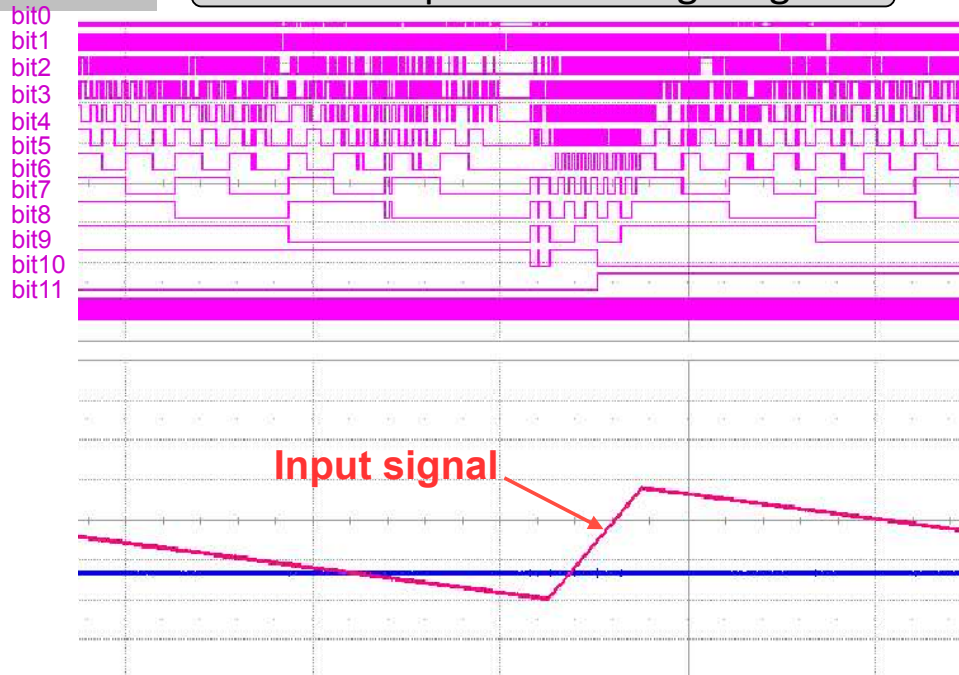
Schematic of ADC-0.2



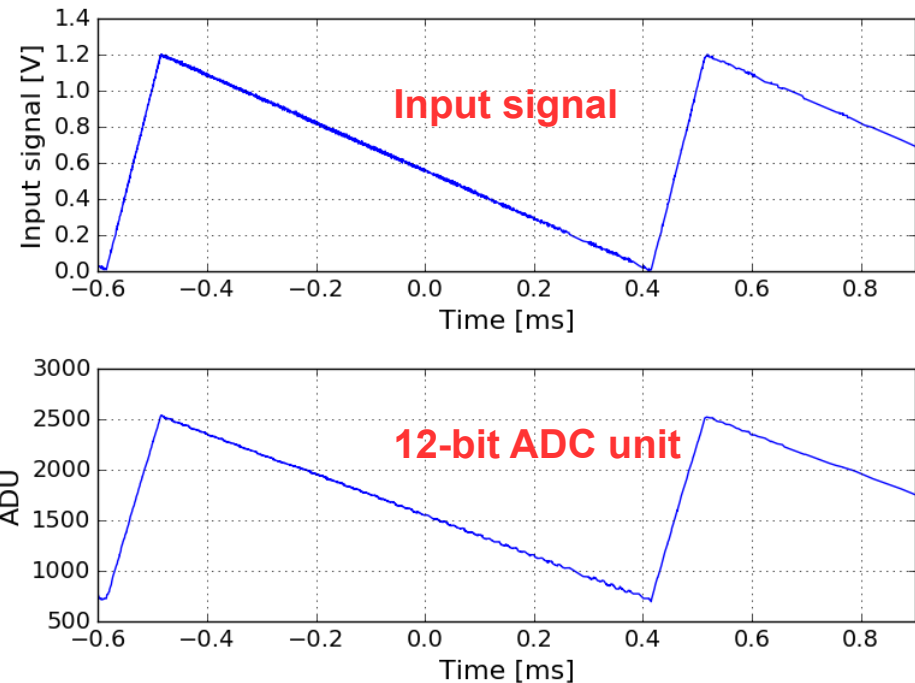
Very first test of ADC-0.2

- ADC 12-bit output
 - 20 MHz ADC clock used
 - Triangle analogue waveform (0 V – 1.2 V) with 1 kHz as input

12-bit output for a triangle signal



ADC unit vs. input signal

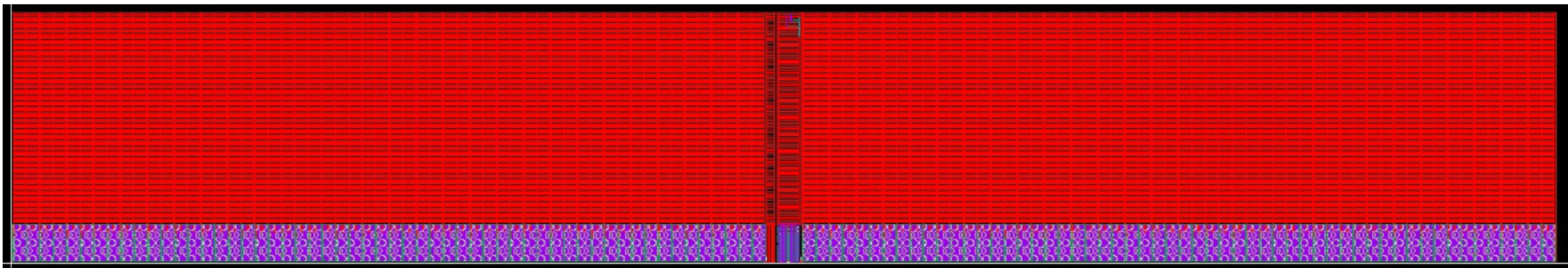


- Basic functionality of ADC-0.2 demonstrated
- Further tests necessary on: noise, linearity, missing codes, etc.

Progress with memory

- Implemented SRAM in ASIC (both schematic and layout, LVS and DRC work)
 - 14 bit per channel: 2 gain bit + 12 bit from ADC for analogue value
 - 1 SRAM unit for 8 channels x 14 bit/channel = 112 bit width
 - 2700 x 112 SRAM unit
 - Area of 380 x 2350 μm^2 per SRAM unit

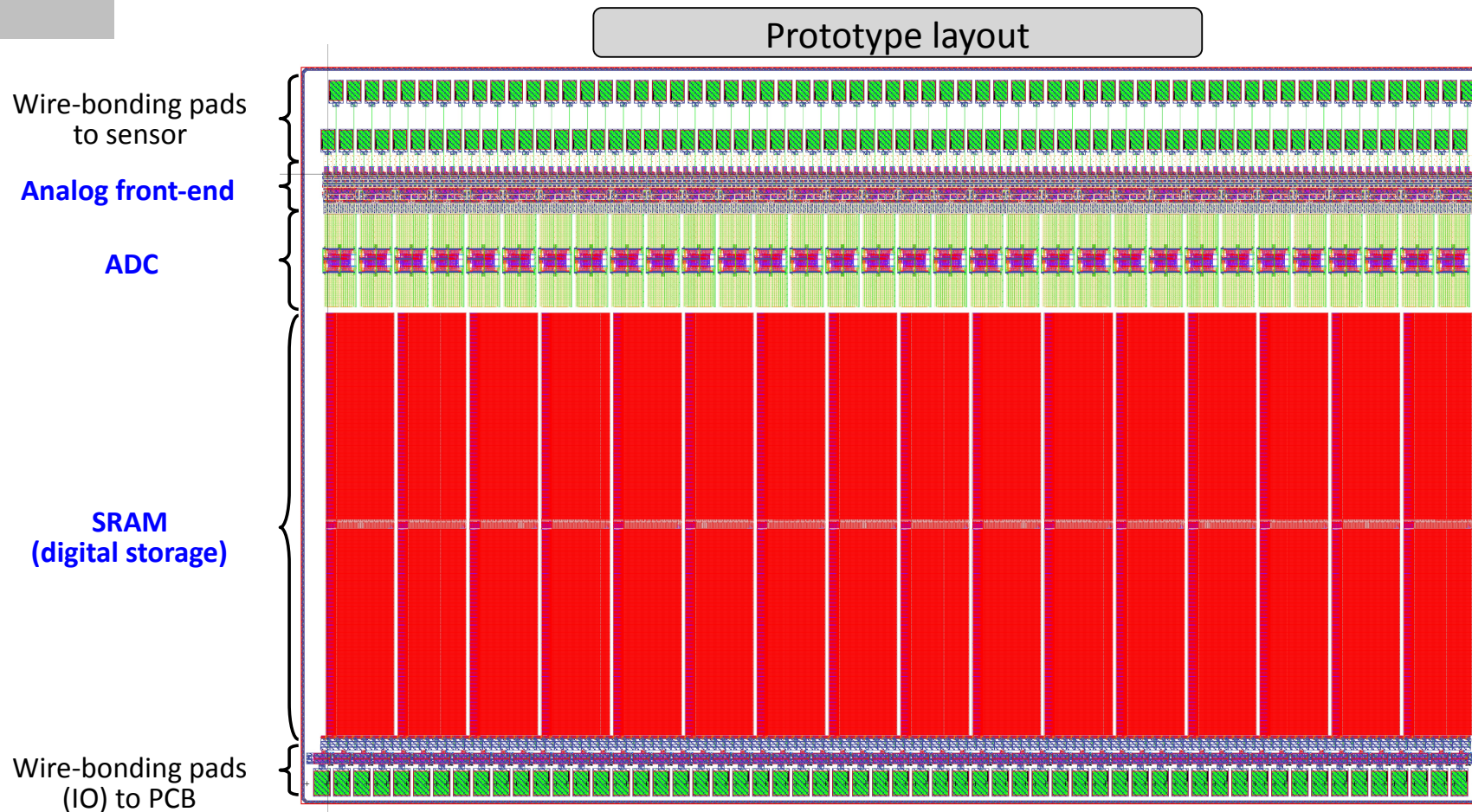
SRAM layout for 8 channels



- On-going work:
 - Design of the timing and control logic between ADC and memory is in progress

Towards the full scale chip

- Realize the timing and control logic between ADC and SRAM in ASIC
- Integration of analog front-end, ADC and SRAM into a prototype
- Submission of prototype end Feb./early March





Summary

- New analogue FE and ADC testing started
 - Looks very promising, full characterisation needs more time
- Next MPW submission in February
 - Full chain: FE, ADC memory
- Engineering run second half 17
- Are on a good way to have first modules end 17/early 18